

<b>Notice of References Cited</b>	Application/Control No. 10/721,468	Applicant(s)/Patent Under Reexamination OYAMA ET AL.	
	Examiner Nguyen T. Ha	Art Unit 2831	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,660,583	12-2003	Fujino et al.	438/253
*	C	US-6,359,769	03-2002	Mushiake et al.	361/502
*	D	US-6,110,335	08-2000	Avarbz et al.	204/294
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	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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